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(MODING) PATERT AND TRADEMARK OFFICE			250247US0			New Application				
11				APPLICANT						
LIST OF	REFEF	RENCES CITED BY AP	PLICANT	Masachika YOSHINO, et al.						
				FILING DATE			GROUP			
				Herewith						
U.S. PATENT DOCUMENTS										
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLAS		SUB FILING DATE CLASS IF APPROPRIATE			
25	AA	2002/0145152	10/10/02	Kenji SHIMOMURA			1			
44	AB	2002/0190262	12/19/02	Koichi NITTA, et al.	7					
74	AC	6,614,172	09/02/03	Chien-Chia CHIU, et al.						
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FOREIGN PATENT DOCUMENTS										
		DOCUMENT NUMBER	DATE	COUNTRY				TRANSLATION YES NO		
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1	AP	7-25987	01/27/95	Japan (with English Abstract)	•				×	
	AQ	2002-327126	11/15/02	Japan (with English Abstract)					×	
	AR	2002-338833	11/27/02	Japan (with English Abstract)					x	
	AS	2002-314139	10/25/02	Japan (with English Abstract and Corre U.S. Patent 2002/0145152)					x	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)										
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	AZ			Additional References sheet(s) attached						
Examiner N/m N Date Co							nsidered 6-24-04			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.										